# INTEGRATED CIRCUITS



Product specification Supersedes data of 1997 Aug 01 IC24 Data Handbook

1998 Apr 28



# 74LVC125A

### **FEATURES**

- 5-volt tolerant inputs/outputs, for interfacing with 5-volt logic
- Supply voltage range of 1.2V to 3.6V
- Complies with JEDEC standard no. 8-1A
- CMOS low power consumption
- Direct interface with TTL levels
- High impedance when V<sub>CC</sub> = 0V

### DESCRIPTION

The 74LVC125A is a high performance, low-power, low-voltage Si-gate CMOS device and superior to most advanced CMOS compatible TTL families.

Inputs can be driven from either 3.3V or 5.0V devices. In 3-state operation, outputs can handle 5V.

The 74LVC125A consists of four non-inverting buffers/line drivers with 3-state outputs. The 3-state outputs (nY) are controlled by the output enable input ( $\overline{\text{OE}}$ ). A HIGH at  $\overline{\text{OE}}$  causes the outputs to assume a high impedance OFF-state.

### QUICK REFERENCE DATA

GND = 0 V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \le 2.5 \text{ ns}$ 

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay nA to nY	C <sub>L</sub> = 50 pF; V <sub>CC</sub> = 3.3 V	3.0	ns
CI	Input capacitance		5.0	pF
C <sub>PD</sub>	Power dissipation capacitance per buffer	V <sub>CC</sub> = 3.3 V Notes 1 and 2	25	pF

#### NOTES:

1.  $C_{PD}$  is used to determine the dynamic power dissipation (P\_D in  $\mu W)$ 

 $P_D = C_{PD} \times V_{CC}{}^2 \times f_i + \sum \left( C_L \times V_{CC}{}^2 \times f_o \right)$  where:

 $f_i$  = input frequency in MHz;  $C_L$  = output load capacity in pF;  $f_0$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;

 $\sum (C_L \times V_{CC}^2 \times f_0) =$  sum of the outputs.

2. The condition is  $V_I = GND$  to  $V_{CC}$ 

### ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
14-Pin Plastic SO	–40°C to +125°C	74LVC125A D	74LVC125A D	SOT108-1
14-Pin Plastic SSOP Type II	–40°C to +125°C	74LVC125A DB	74LVC125A DB	SOT337-1
14-Pin Plastic TSSOP Type I	-40°C to +125°C	74LVC125A PW	7LVC125APW DH	SOT402-1

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### **PIN CONFIGURATION**



### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1, 4, 10, 13	$1\overline{OE} - 4\overline{OE}$	Data enable inputs (active LOW)
2, 5, 9, 12	1A – 4A	Data inputs
3, 6, 8, 11	1Y – 4Y	Data Outputs
7	GND	Ground (0 V)
14	V <sub>CC</sub>	Positive supply voltage

### LOGIC SYMBOL



### **FUNCTION TABLE**

INP	OUTPUT	
nOE	nA	nY
L	L	L
L	Н	н
н	х	Z

NOTES:

H = HIGH voltage level L = LOW voltage level X = don't care

Z = high impedance OFF-state

### LOGIC SYMBOL (IEEE/IEC)



### 74LVC125A

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	DADAMETED	CONDITIONS	LIM	UNIT	
STWIBOL	PARAMETER	CONDITIONS	MIN	MAX	
M	DC supply voltage (for max. speed performance)		2.7	3.6	v
V <sub>CC</sub>	DC supply voltage (for low-voltage applications)		1.2	3.6	v
VI	DC input voltage range		0	5.5	V
Vo	DC output voltage range; output HIGH or LOW state		0	V <sub>CC</sub>	V
-	DC output voltage range; output 3-State		0	5.5	]
T <sub>amb</sub>	Operating ambient temperature range in free-air		-40	+85	°C
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	$V_{CC} = 1.2 \text{ to } 2.7 \text{V}$ $V_{CC} = 2.7 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V

### **ABSOLUTE MAXIMUM RATINGS<sup>1</sup>**

In accordance with the Absolute Maximum Rating System (IEC 134) Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +6.5	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-50	mA
VI	DC input voltage	Note 2	-0.5 to +6.5	V
I <sub>OK</sub>	DC output diode current	$V_{O} > V_{CC} \text{ or } V_{O} < 0$	±50	mA
V	DC output voltage; output HIGH or LOW state	Note 2	–0.5 to V <sub>CC</sub> +0.5	V
Vo	DC output voltage; output 3-State	Note 2	-0.5 to 6.5	v
I <sub>OUT</sub>	DC output source or sink current	$V_{O} = 0$ to $V_{CC}$	±50	mA
I <sub>GND</sub> , I <sub>CC</sub>	DC V <sub>CC</sub> or GND current		±100	mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C
P <sub>TOT</sub>	Power dissipation per package – plastic mini-pack (SO) – plastic shrink mini-pack (SSOP and TSSOP)	above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	500 500	mW

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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### **DC ELECTRICAL CHARACTERISTICS**

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

			L			
SYMBOL	PARAMETER	TEST CONDITIONS	Temp = -	40°C to	+85°C	
			MIN	TYP <sup>1</sup>	МАХ	1
M	HIGH level Input voltage	$V_{CC} = 1.2V$	V <sub>CC</sub>			V
V <sub>IH</sub>		V <sub>CC</sub> = 2.7 to 3.6V	2.0			
V		$V_{CC} = 1.2V$			GND	v
V <sub>IL</sub>	LOW level Input voltage	V <sub>CC</sub> = 2.7 to 3.6V			0.8	1 ×
		$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -12mA$	V <sub>CC</sub> -0.5			
M		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -100 \mu A$	V <sub>CC</sub> -0.2	V <sub>CC</sub>		v
V <sub>OH</sub> HIGH level output voltage	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -18\text{mA}$	V <sub>CC</sub> -0.6			v	
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -24\text{mA}$	V <sub>CC</sub> -0.8			1
		$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 12mA$			0.40	
V <sub>OL</sub>	LOW level output voltage	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		GND	0.20	V
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} I_O = 24\text{mA}$			0.55	1
ł <sub>l</sub>	Input leakage current	$V_{CC} = 3.6V; V_1 = 5.5V \text{ or GND}$		±0.1	±5	μΑ
I <sub>OZ</sub>	3-State output OFF-state current <sup>2</sup>	$V_{CC} = 3.6V; V_I = V_{IH} \text{ or } V_{IL}; V_O = 5.5V \text{ or GND}$		0.1	±5	μΑ
I <sub>off</sub>	Power off leakage supply	$V_{CC} = 0.0V; V_1 \text{ or } V_0 = 5.5V$		0.1	±10	μΑ
I <sub>CC</sub>	Quiescent supply current	$V_{CC} = 3.6V; V_{I} = V_{CC} \text{ or GND}; I_{O} = 0$		0.1	10	μΑ
$\Delta I_{CC}$	Additional quiescent supply current per input pin	$V_{CC}$ = 2.7V to 3.6V; $V_{I}$ = $V_{CC}$ –0.6V; $I_{O}$ = 0		5	500	μA

#### NOTE:

1. All typical values are at  $V_{CC}$  = 3.3V and  $T_{amb}$  = 25°C. 2. For I/O ports the parameter I<sub>OZ</sub> includes the input leakage current.

### **AC CHARACTERISTICS**

GND = 0 V;  $t_r = t_f = 2.5 \text{ ns}$ ;  $C_L = 50 \text{ pF}$ ;  $R_L = 500\Omega$ 

					l	LIMITS			
SYMBOL	PARAMETER	WAVEFORM	V <sub>CC</sub>	= 3.3V ±0	).3V	V <sub>CC</sub> =	: 2.7V	V <sub>CC</sub> = 1.2V	UNIT
			MIN	TYP <sup>1</sup>	MAX	MIN	MAX	ТҮР	
t <sub>PHL</sub> t <sub>PLH</sub>	Propagation delay nA to nY	Figures 1, 3	1.5	3.0	4.8	1.5	5.5	12.0	ns
t <sub>PZH</sub> t <sub>PZL</sub>	3-State output enable time nOE to nY	Figures 2, 3	1.5	3.8	5.7	1.5	6.7	13.0	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	3-State output disable time nOE to nY	Figures 2, 3	1.5	3.7	5.2	1.5	6.2	8	ns

NOTE:

1. These typical values are at V<sub>CC</sub> = 3.3V and T<sub>amb</sub> =  $25^{\circ}$ C.

SW00047

# Quad buffer/line driver with 5-volt tolerant inputs/outputs (3-state)

# 74LVC125A

### AC WAVEFORMS

 $V_M$  = 1.5 V at  $V_{CC} \geq$  2.7 V;  $V_M$  = 0.5 •  $V_{CC}$  at  $V_{CC}$  < 2.7 V  $V_{OL}$  and  $V_{OH}$  are the typical output voltage drop that occur with the output load.

 $\begin{array}{l} \mathsf{V_X} = \mathsf{V_{OL}} + 0.3 \; \forall \; at \; \mathsf{V_{CC}} \geq 2.7 \; \lor \\ \mathsf{V_X} = \mathsf{V_{OL}} + 0.1 \; \forall \; at \; \mathsf{V_{CC}} > 2.7 \; \lor \\ \mathsf{V_Y} = \mathsf{V_{OH}} - 0.3 \; \lor \; at \; \mathsf{V_{CC}} \geq 2.7 \; \lor \\ \mathsf{V_Y} = \mathsf{V_{OH}} - 0.1 \; \lor \; at \; \mathsf{V_{CC}} < 2.7 \; \lor \\ \end{array}$ 



Figure 1. Input (nA) to output (nY) propagation delays.



Figure 2. 3-state enable and disable times.

### **TEST CIRCUIT**



Figure 2. Lood einewitze for ewitching time

Figure 3. Load circuitry for switching times.

### 74LVC125A

Product specification



#### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFERENCES EUROPEAN				ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT108-1	076E06S	MS-012AB				<del>91-08-13</del> 95-01-23

# 74LVC125A

Product specification



Product specification

### 74LVC125A



OUTLINE		REFERENCES				ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT402-1		MO-153				<del>-94-07-12-</del> 95-04-04

### Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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